

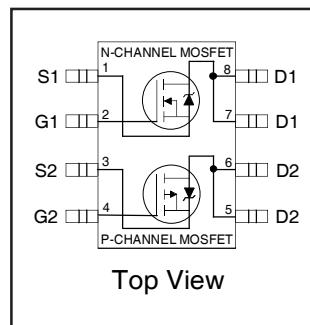
## Features

- Advanced Planar Technology
- Ultra Low On-Resistance
- Logic Level Gate Drive
- Dual N and P Channel MOSFET
- Surface Mount
- Available in Tape & Reel
- 150°C Operating Temperature
- Automotive [Q101] Qualified\*
- Lead-Free, RoHS Compliant

## Description

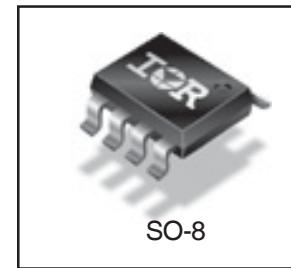
Specifically designed for Automotive applications, these HEXFET® Power MOSFET's in a Dual SO-8 package utilize the lastest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of these Automotive qualified HEXFET Power MOSFET's are a 150°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These benefits combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

The efficient SO-8 package provides enhanced thermal characteristics and dual MOSFET die capability making it ideal in a variety of power applications. This dual, surface mount SO-8 can dramatically reduce board space and is also available in Tape & Reel.



## HEXFET® Power MOSFET

	N-Ch	P-Ch
$V_{(BR)DSS}$	55V	-55V
$R_{DS(on)}$	typ.	0.043Ω
	max.	0.050Ω
$I_D$	4.7A	-3.4A



G	D	S
Gate	Drain	Source

Base Part Number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
AUIRF7343Q	SO-8	Tube	95	AUIRF7343Q
		Tape and Reel	4000	AUIRF7343QTR

## Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature ( $T_A$ ) is 25°C, unless otherwise specified.

	Parameter	Max.		Units
		N-Channel	P-Channel	
$V_{DS}$	Drain-Source Voltage	55	-55	V
$I_D$ @ $T_A = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$	4.7	-3.4	A
$I_D$ @ $T_A = 70^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$	3.8	-2.7	
$I_{DM}$	Pulsed Drain Current ①	38	-27	
$P_D$ @ $T_A = 25^\circ\text{C}$	Power Dissipation ⑤	2.0		W
$P_D$ @ $T_A = 70^\circ\text{C}$	Power Dissipation ⑤	1.3		
$E_{AS}$	Single Pulse Avalanche Energy ③	72	114	mJ
$I_{AR}$	Avalanche Current	4.7	-3.4	A
$E_{AR}$	Repetitive Avalanche Energy	0.20		mJ
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$		V
$dv/dt$	Peak Diode Recovery $dv/dt$ ②	5.0	-5.0	V/ns
$T_J$	Operating Junction and	-55 to + 150		°C
$T_{STG}$	Storage Temperature Range			

## Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{θJA}$	Junction-to-Ambient ⑥	—	62.5	°C/W

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\*Qualification standards can be found at <http://www.irf.com/>

Static Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise stated)

Parameter		Min.	Typ.	Max.	Units	Conditions	
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	N-Ch	55	—	—	$V_{GS} = 0V, I_D = 250\mu\text{A}$ $V_{GS} = 0V, I_D = -250\mu\text{A}$	
		P-Ch	-55	—	—		
$\Delta V_{(\text{BR})\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	N-Ch	—	0.059	—	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$ Reference to $25^\circ\text{C}$ , $I_D = -1\text{mA}$	
		P-Ch	—	0.054	—		
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	N-Ch	—	0.043	0.050	$V_{GS} = 10V, I_D = 4.7\text{A}$ ④ $V_{GS} = 4.5V, I_D = 3.8\text{A}$ ④ $V_{GS} = -10V, I_D = -3.4\text{A}$ ④ $V_{GS} = -4.5V, I_D = -2.7\text{A}$ ④	
			—	0.056	0.065		
		P-Ch	—	0.095	0.105		
			—	0.150	0.170		
$V_{GS(\text{th})}$	Gate Threshold Voltage	N-Ch	1.0	—	—	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$ $V_{DS} = V_{GS}, I_D = -250\mu\text{A}$	
		P-Ch	-1.0	—	—		
$g_{fs}$	Forward Transconductance	N-Ch	7.9	—	—	$V_{DS} = 10V, I_D = 4.5\text{A}$ ④ $V_{DS} = -10V, I_D = -3.1\text{A}$ ④	
		P-Ch	3.3	—	—		
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	N-Ch	—	—	2.0	$V_{DS} = 55V, V_{GS} = 0V$ $V_{DS} = -55V, V_{GS} = 0V$ $V_{DS} = 55V, V_{GS} = 0V, T_J = 55^\circ\text{C}$ $V_{DS} = -55V, V_{GS} = 0V, T_J = 55^\circ\text{C}$	
			—	—	-2.0		
		P-Ch	—	—	25		
			—	—	-25		
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	—	± 100	nA	$V_{GS} = \pm 20V$

Dynamic Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise stated)

Parameter		Min.	Typ.	Max.	Units	Conditions
$Q_g$	Total Gate Charge	N-Ch	—	24	36	N-Channel $I_D = 4.5\text{A} V_{DS} = 44V, V_{GS} = 10V$
		P-Ch	—	26	38	
$Q_{gs}$	Gate-to-Source Charge	N-Ch	—	2.3	3.4	P-Channel $I_D = -3.1\text{A} V_{DS} = -44V, V_{GS} = -10V$ ④
		P-Ch	—	3.0	4.5	
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	N-Ch	—	7.0	10	
		P-Ch	—	8.4	13	
$t_{d(on)}$	Turn-On Delay Time	N-Ch	—	8.3	12	N-Channel $V_{DD} = 28V, I_D = 1.0\text{A}, R_G = 6.0\Omega$
		P-Ch	—	14	22	
$t_r$	Rise Time	N-Ch	—	3.2	4.8	R <sub>D</sub> = 28Ω P-Channel $V_{DD} = -28V, I_D = -1.0\text{A}, R_G = 6.0\Omega$ ④
		P-Ch	—	10	15	
$t_{d(off)}$	Turn-Off Delay Time	N-Ch	—	32	48	R <sub>D</sub> = 28Ω
		P-Ch	—	43	64	
$t_f$	Fall Time	N-Ch	—	13	20	
		P-Ch	—	22	32	
$C_{iss}$	Input Capacitance	N-Ch	—	740	—	N-Channel $V_{GS} = 0V, V_{DS} = 25V, f = 1.0\text{MHz}$
		P-Ch	—	690	—	
$C_{oss}$	Output Capacitance	N-Ch	—	190	—	P-Channel $V_{GS} = 0V, V_{DS} = -25V, f = 1.0\text{MHz}$
		P-Ch	—	210	—	
$C_{rss}$	Reverse Transfer Capacitance	N-Ch	—	71	—	
		P-Ch	—	86	—	

## Diode Characteristics

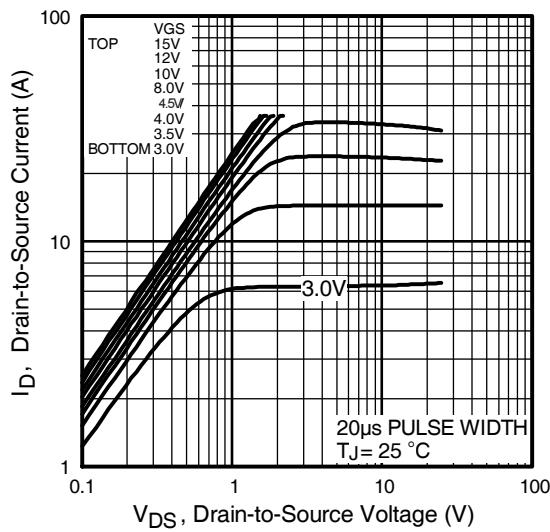
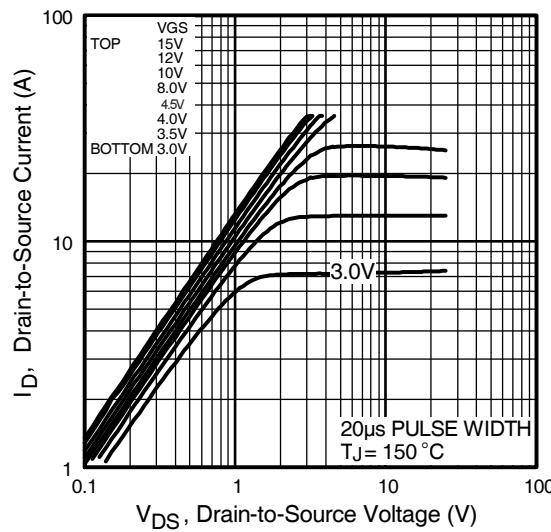
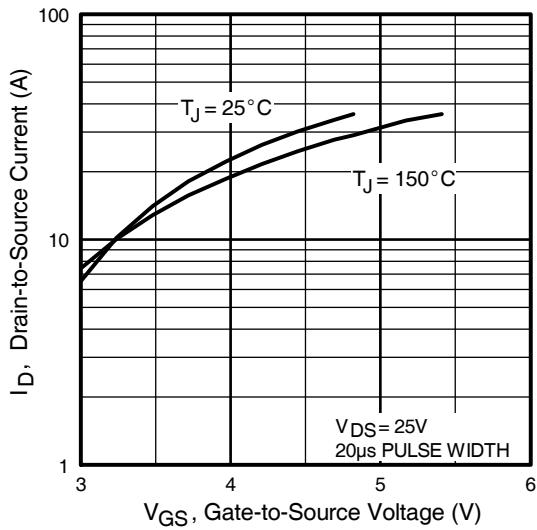
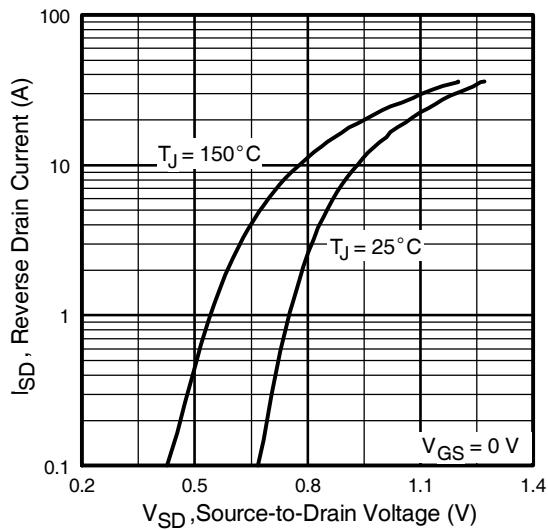
Parameter		Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	N-Ch	—	2.0	A	
		P-Ch	—	-2.0		
$I_{SM}$	Pulsed Source Current (Body Diode) ①	N-Ch	—	38		
		P-Ch	—	-27		
$V_{SD}$	Diode Forward Voltage	N-Ch	—	0.70	1.2	$T_J = 25^\circ\text{C}, I_S = 2.0\text{A}, V_{GS} = 0V$ ③ $T_J = 25^\circ\text{C}, I_S = -2.0\text{A}, V_{GS} = 0V$ ③
		P-Ch	—	-0.80	-1.2	
$t_{rr}$	Reverse Recovery Time	N-Ch	—	60	90	N-Channel $T_J = 25^\circ\text{C}, I_F = 2.0\text{A} \frac{dI}{dt} = 100\text{A}/\mu\text{s} f$
		P-Ch	—	54	80	
$Q_{rr}$	Reverse Recovery Charge	N-Ch	—	120	170	P-Channel $T_J = 25^\circ\text{C}, I_F = -2.0\text{A} \frac{dI}{dt} = 100\text{A}/\mu\text{s} f$ ④
		P-Ch	—	85	130	

## Notes:

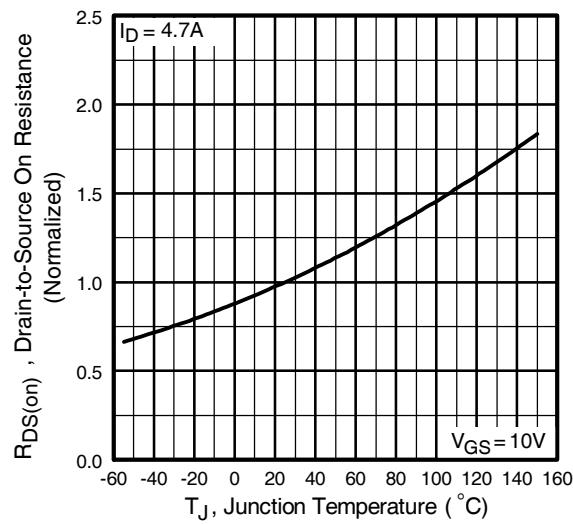
① Repetitive rating; pulse width limited by max. junction temperature.  
(See fig. 22)  
② N-Channel  $I_{SD} \leq 4.7\text{A}$ ,  $\frac{dI}{dt} \leq 220\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(\text{BR})\text{DSS}}$ ,  $T_J \leq 150^\circ\text{C}$   
P-Channel  $I_{SD} \leq -3.4\text{A}$ ,  $\frac{dI}{dt} \leq -150\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(\text{BR})\text{DSS}}$ ,  $T_J \leq 150^\circ\text{C}$

③ N-Channel Starting  $T_J = 25^\circ\text{C}$ ,  $L = 6.5\text{mH}$   $R_G = 25\Omega$ ,  $I_{AS} = 4.7\text{A}$ .  
P-Channel Starting  $T_J = 25^\circ\text{C}$ ,  $L = 20\text{mH}$   $R_G = 25\Omega$ ,  $I_{AS} = -3.4\text{A}$ .  
④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .  
⑤ Surface mounted on FR-4 board,  $t \leq 10\text{sec}$ .

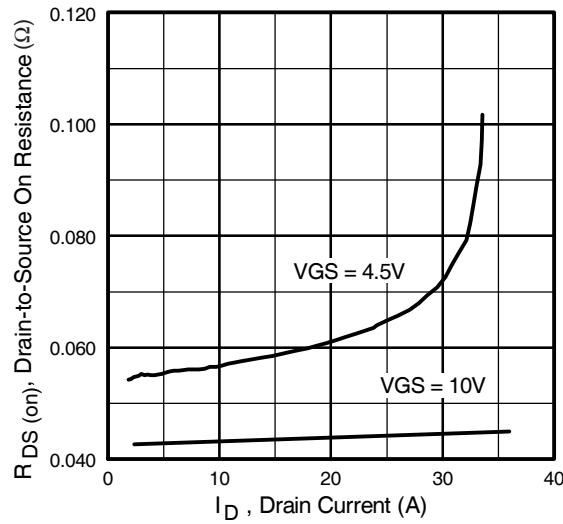
## N-Channel

**Fig 1.** Typical Output Characteristics**Fig 2.** Typical Output Characteristics**Fig 3.** Typical Transfer Characteristics**Fig 4.** Typical Source-Drain Diode Forward Voltage

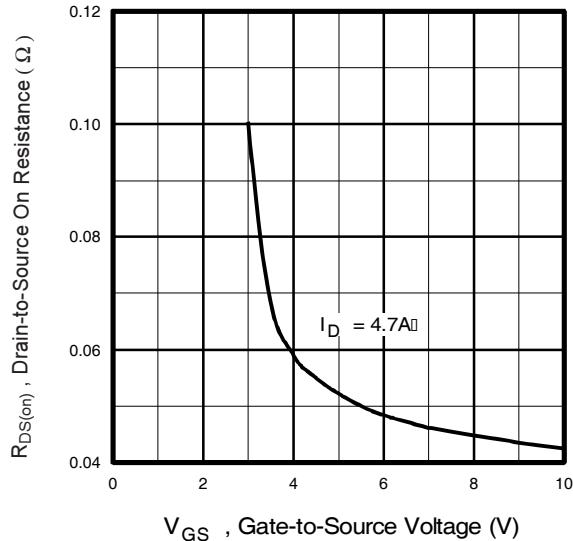
## N-Channel



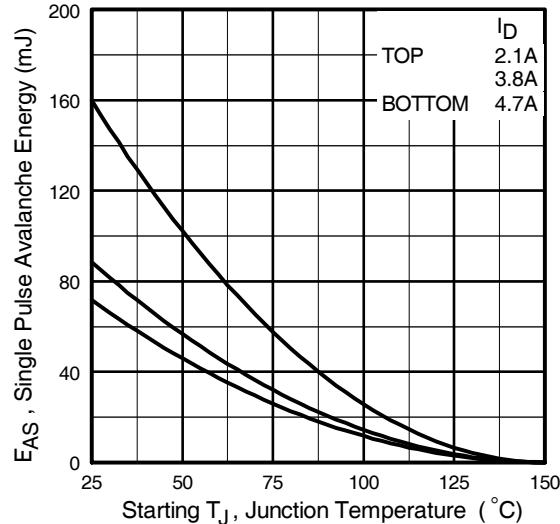
**Fig 5.** Normalized On-Resistance Vs. Temperature



**Fig 6.** Typical On-Resistance Vs. Drain Current

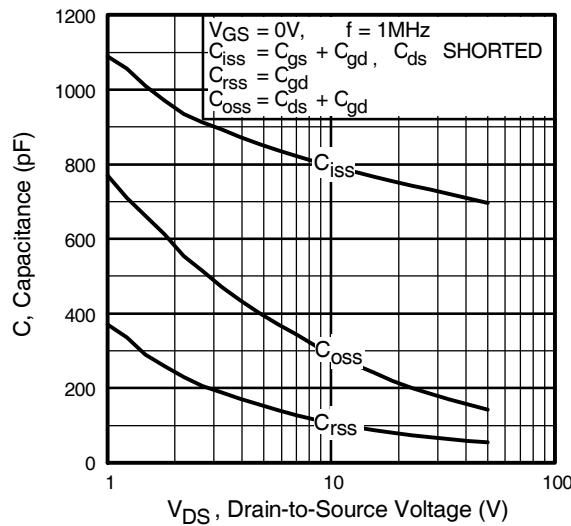


**Fig 7.** Typical On-Resistance Vs. Gate Voltage

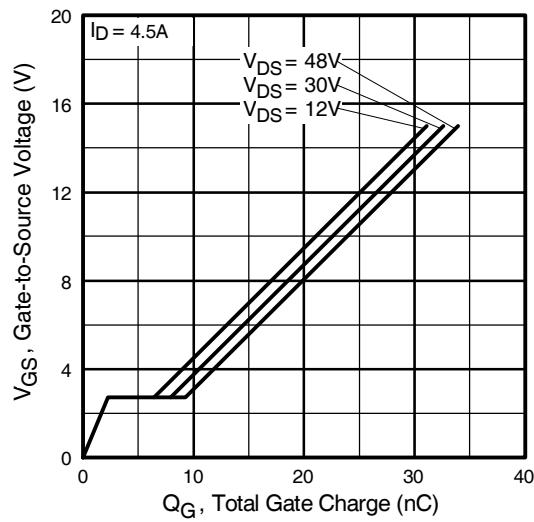


**Fig 8.** Maximum Avalanche Energy Vs. Drain Current

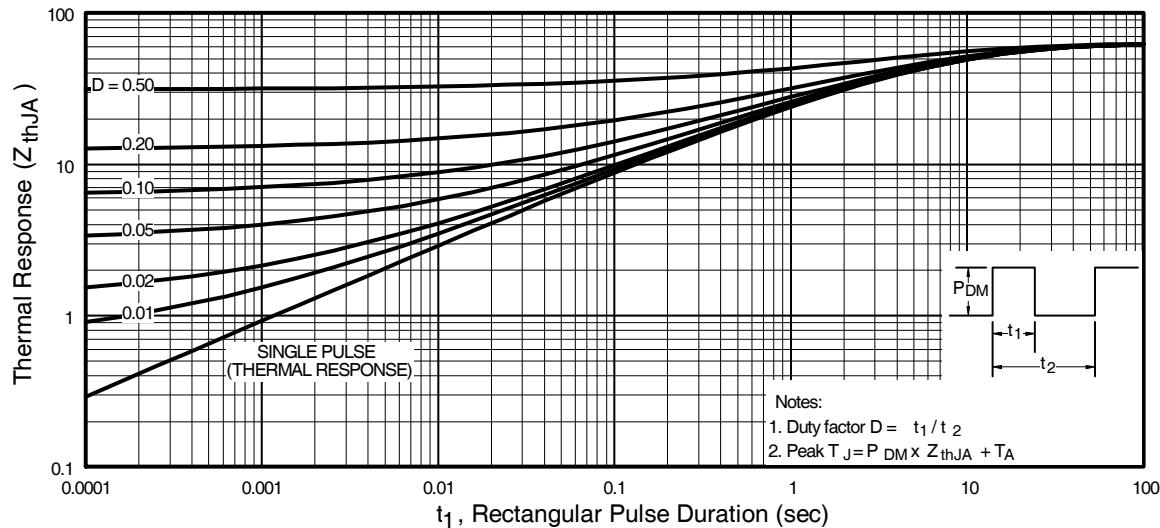
## N-Channel



**Fig 9.** Typical Capacitance Vs.  
Drain-to-Source Voltage

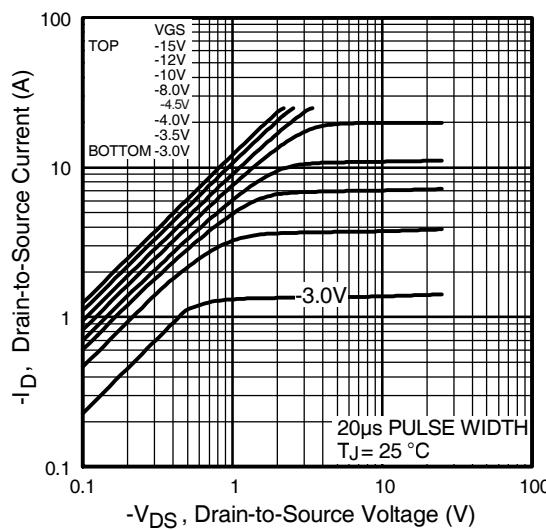
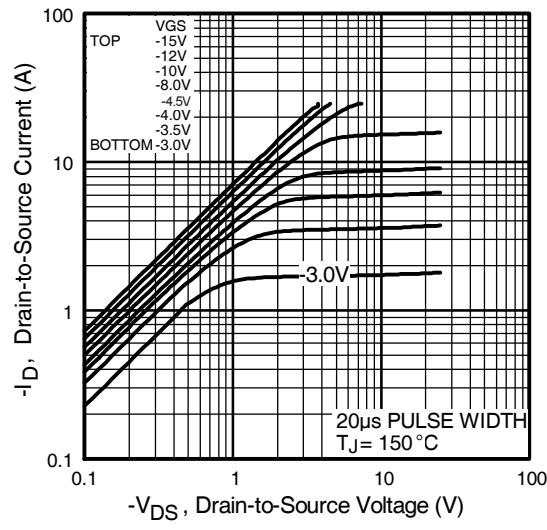
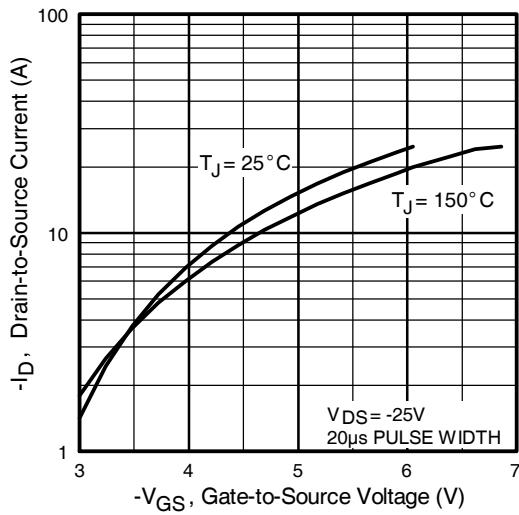
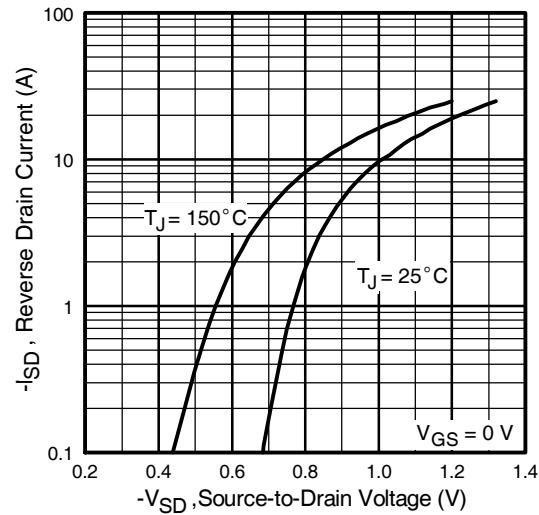


**Fig 10.** Typical Gate Charge Vs.  
Gate-to-Source Voltage

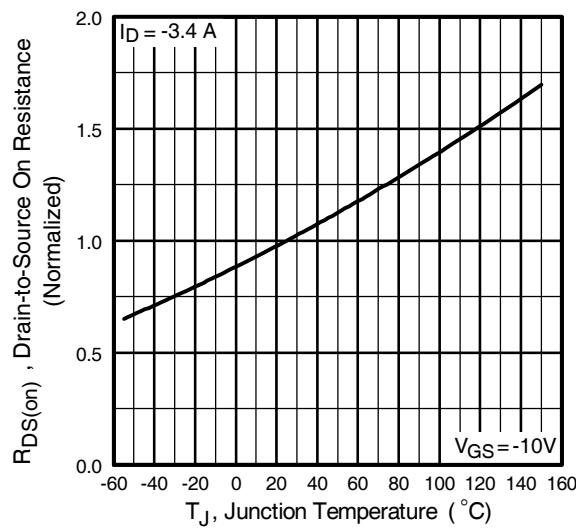


**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

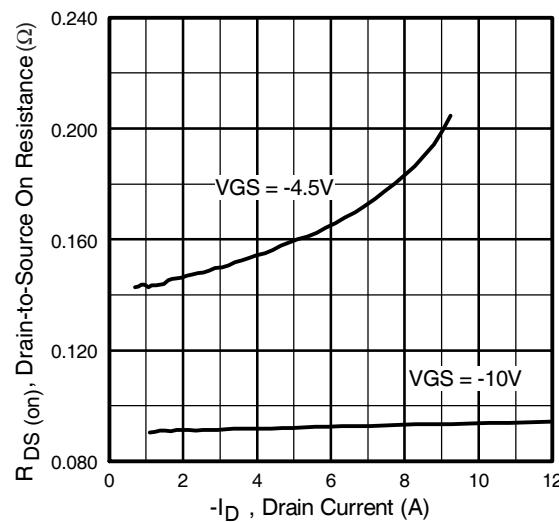
## P-Channel

**Fig 12.** Typical Output Characteristics**Fig 13.** Typical Output Characteristics**Fig 14.** Typical Transfer Characteristics**Fig 15.** Typical Source-Drain Diode Forward Voltage

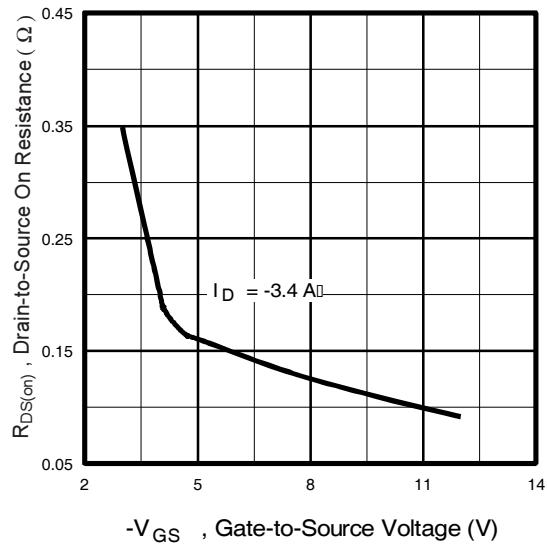
## P-Channel



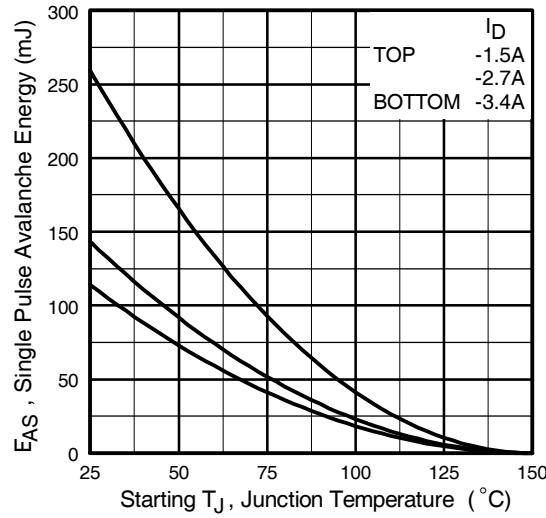
**Fig 16.** Normalized On-Resistance Vs. Temperature



**Fig 17.** Typical On-Resistance Vs. Drain Current

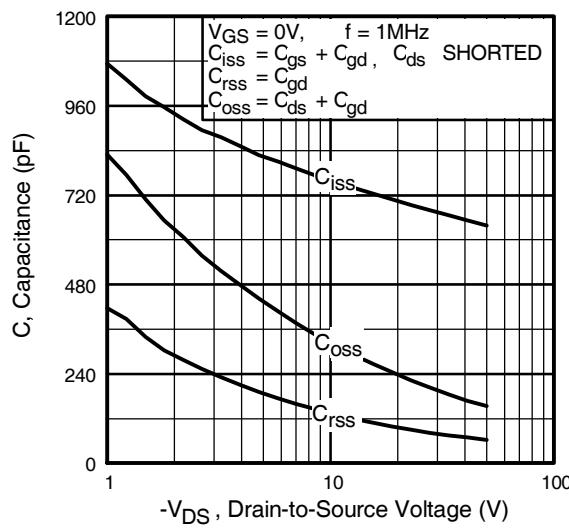


**Fig 18.** Typical On-Resistance Vs. Gate Voltage

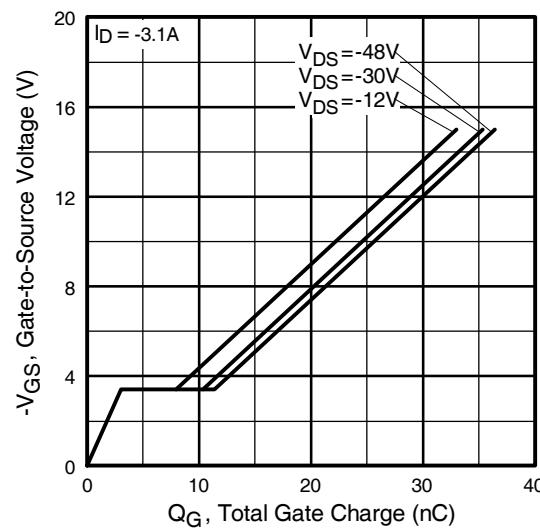


**Fig 19.** Maximum Avalanche Energy Vs. Drain Current

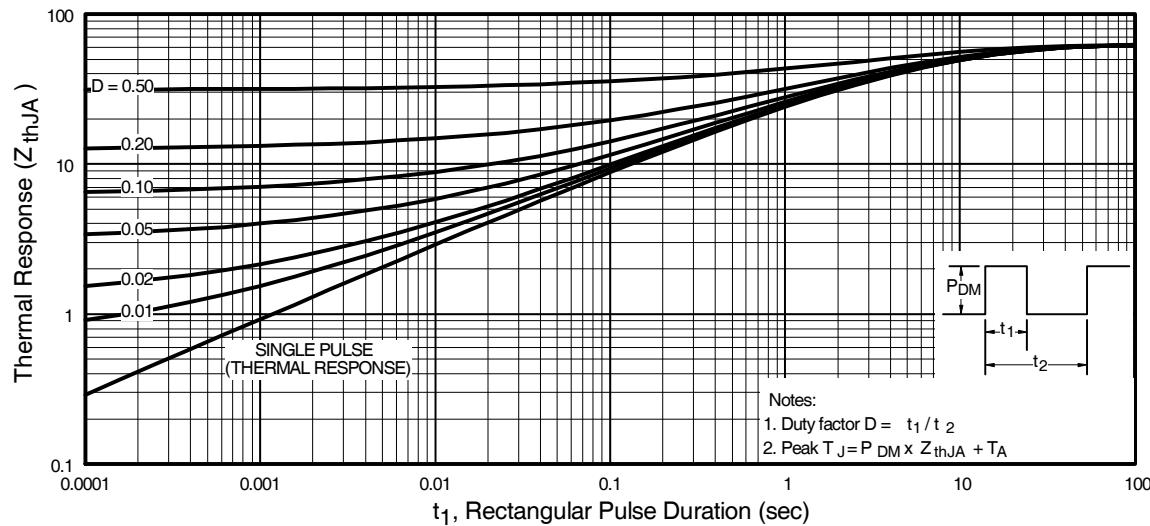
## P-Channel



**Fig 20.** Typical Capacitance Vs.  
Drain-to-Source Voltage



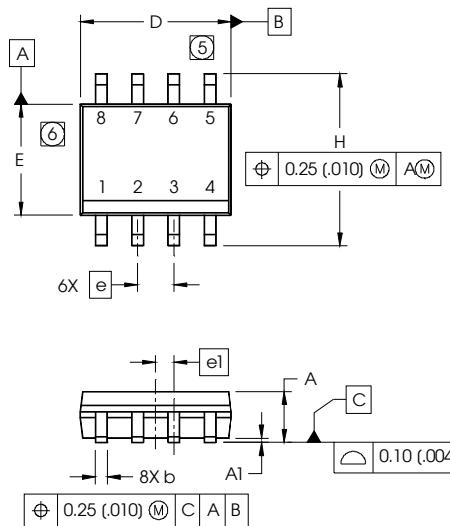
**Fig 21.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



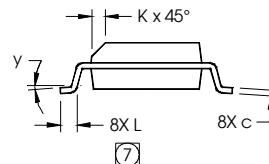
**Fig 22.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

## SO-8 Package Outline

Dimensions are shown in millimeters (inches)

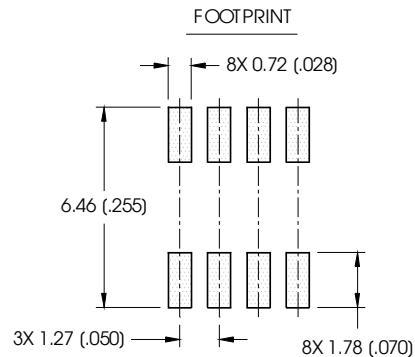


DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
b	.013	.020	0.33	0.51
c	.0075	.0098	0.19	0.25
D	.189	.1968	4.80	5.00
E	.1497	.1574	3.80	4.00
e	.050	BASIC	1.27	BASIC
e1	.025	BASIC	0.635	BASIC
H	.2284	.2440	5.80	6.20
K	.0099	.0196	0.25	0.50
L	.016	.050	0.40	1.27
y	0°	8°	0°	8°

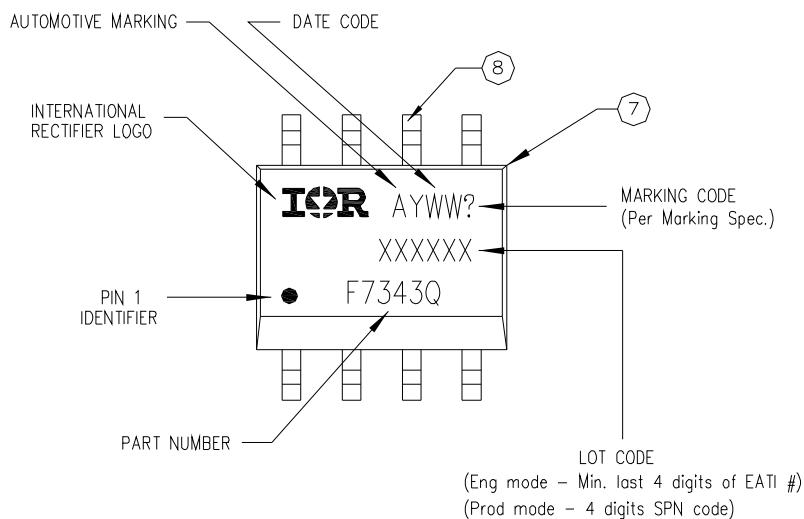


### NOTES:

1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA
- 5) DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 (.006).
- 6) DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 (.010).
- 7) DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.



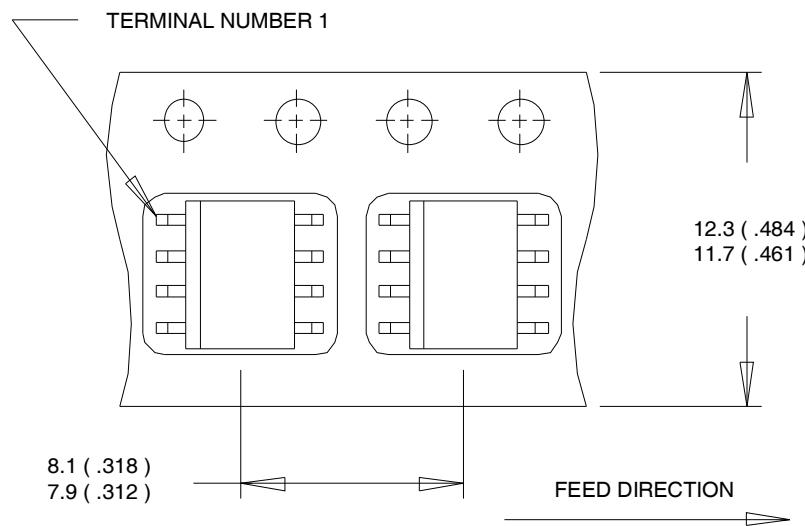
## SO-8 Part Marking



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

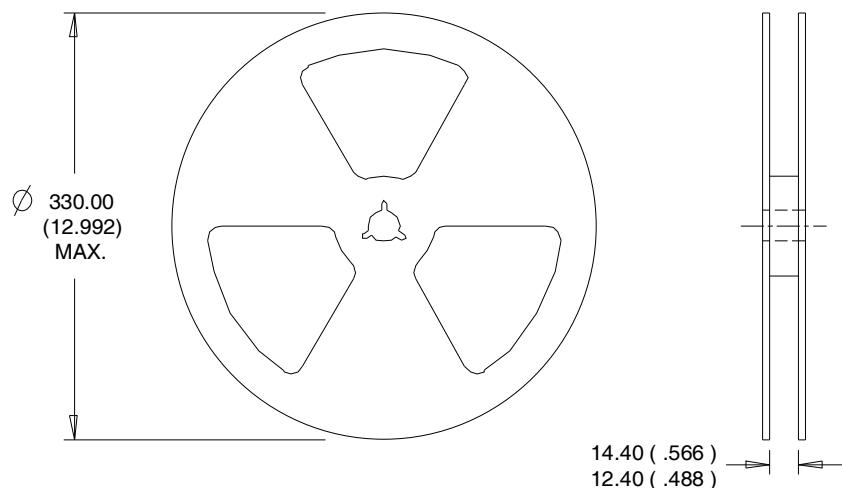
**SO-8 Tape and Reel**

Dimensions are shown in millimeters (inches)



## NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



## NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

**Qualification Information<sup>†</sup>**

<b>Qualification Level</b>		Automotive (per AEC-Q101) <sup>††</sup>	
Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
<b>Moisture Sensitivity Level</b>		SO-8	MSL1
<b>ESD</b>	Machine Model	Class M2 (200V) <sup>†††</sup> (per AEC-Q101-002)	
	Human Body Model	Class H1A (500V) <sup>†††</sup> (per AEC-Q101-001)	
	Charged Device Model	Class C5 (1125V) <sup>†††</sup> (per AEC-Q101-005)	
<b>RoHS Compliant</b>		Yes	

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/>

<sup>††</sup> Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.

<sup>†††</sup> Highest passing voltage

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For technical support, please contact IR's Technical Assistance Center  
<http://www.irf.com/technical-info/>

**WORLD HEADQUARTERS:**  
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Tel: (310) 252-7105

**Revision History**

Date	Comments
3/10/2014	<ul style="list-style-type: none"><li>• Added "Logic Level Gate Drive" bullet in the features section on page 1</li><li>• Updated data sheet with new IR corporate template</li></ul>